Patent

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of

Silke DRABER

Application No.: 09/521,107

Filed: March 7, 2000

For: METHOD FOR ASSESSING THE RELIABILITY OF TECHNICAL SYSTEMS

Attorney's Docket No. 004501-349

Group Art Unit: 2786

Examiner: Unassigned

From METHOD FOR ASSESSING THE RELIABILITY OF TECHNICAL SYSTEMS

INFORMATION DISCLOSURE STATEMENT
TRANSMITTAL LETTER

Assistant Commissioner for Patents Washington, D.C. 20231

Sir:

Enclosed is an Information Disclosure Statement and accompanying form PTO-1449 for the above-identified patent application.

[X]	No additional fee for submission of an IDS is required.
[]	The fee of \$240.00 (126) as set forth in 37 C.F.R. § 1.17(p) is also enclosed.
[]	A certification under 37 C.F.R. § 1.97(e) is also enclosed.
[]	A certification under 37 C.F.R. § 1.97(e), a petition requesting consideration of the
	information disclosure statement, and the petition fee of \$130.00 (122) as set forth
	in 37 C.F.R. § 1.17(i) are also enclosed.
[]	Charge \$ to Deposit Account No. 02-4800 for the fee due.
[]	A check in the amount of \$ is enclosed for the fee due.

Information Disclosure Statement Transmittal Letter
Application No. 09/521,107
Attorney's Docket No. 004501-349
Page 2

The Commissioner is hereby authorized to charge any appropriate fees under 37 C.F.R. §§ 1.16, 1.17 and 1.21 that may be required by this paper, and to credit any overpayment, to Deposit Account No. 02-4800. This paper is submitted in duplicate.

Respectfully submitted,

BURNS, DOANE, SWECKER & MATHIS, L.L.P.

y:______

Elaine Papavasiliou Registration No. 40,116

P.O. Box 1404 Alexandria, Virginia 22313-1404 (703) 836-6620

Date: September 12, 2000

ABB Research Ltd ZÜRICH / SWITZERLAND

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of
Silke DRABER, Dr.

Claiming Priority under 35 U.S.C. 119
of application No.:
199 10 098.5
in:
GERMANY
with filing date of:
08/March 1999
U.S. Serial Number:
09/521, 107
U.S. filing date:
317/00

Title: ;ethod for assessing the reliability of technical systems

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

Honorable Commissioner of Patents and Trademarks, Washington, D.C. 20231

Sir:

Submitted herewith is a Search Report/Examination Report issued in a corresponding foreign patent application by the

European Patent Office (x)
German Patent Office ()
()

- 1. We wish to make of record the certain citations listed in the Search Report/ Examination Report in accordance with 37 CFR 1.97.
- 2. The relevance of each listed item with regard to the different claims of the above-identified application according to the opinion of the Search Authority/Examination Authority, is indicated in the Search Report/Examination Report

by reference to certain categories which are explained on the Report sheet or in MPEP on page 1800 - 55, resp. (x)

5. The claims as filed in the above-iden	5. The claims as filed in the above-identified 0.5. patent application						
correspond to	(x)						
are different from	()						
the claims for which the Search Report/Examination Report has been established.							
4. Copies of the references cited are er	nclosed herewith.						
All citations	(x)						
All relevant citations except U.S. patents	()						
 English translations of pertinent portions of any non-English references are enclosed herewith, if such translation is readily available. No copies are enclosed herewith of references which are characterized by an "A" in the Search Report/Examination Report, since "A" indicates that such reference is not relevant for the invention. () Additionally, copies of the references cited in the specification are enclosed. () 							
Date: 29 th August 2000	Respectfully submitted, by: Markus Müller						

INFORMATION DISCLOSURE				ATTORNEY'S DKT NO. 004501-349		APPLICATION NO. 09/521,107		
	CITA		001.2	APPLICANT Silke Draber				,
V)				FILING DATE		GROUP		7
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INITIALS	PATENT NO.	DATE		NAME	CLASS	SUBCLASS		<u> </u>
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	OTHER DOC	CUMENTS (In	cluding Author	r, Title, Date, Perti	inent Pag	es, Etc.)		
	T. Onisawa, "/	A Model of S	ubjective Relia	bility Analysis" XP	-000910	587, pp. 756	-761	
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EXAMINER				OATE CONSIDERED)			

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance <u>and</u> not considered. Include copy of this form with next communication to applicant.